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CIT-7, a Crystalline, Molecular Sieve with Pores Bounded by 8 and 10-Membered Rings

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Supporting Information

1. Microporous Material Synthesis Results

Table S1. Fluoride mediated synthesis results.

Gel Ratios						Produc	t Ratios ^b	
Si/Al	Si/Ti	H ₂ O/SiO ₂	Seeds	Temp (°C)	Time (days)	Result	Si/Al	Si/Ti
∞	-	4	None	175	8	STW ^a	-	-
∞	-	4	None	175	6	STW +CIT-7 ^a	-	-
∞	-	4	None	175	6	CIT-7 ^a	-	-
∞	-	4	Silica CIT-7	175	6	CIT-7	-	-
∞	-	7	None	175	6	STW	-	-
15	-	4	Silica CIT-7	175	5	CIT-7	10	-
20	-	4	None	175	20	CIT-7	14	-
20	-	4	None	175	12	CIT-7	13	-
25	-	4	Silica CIT-7	175	5	CIT-7	15	-
25	-	4	Silica CIT-7	175	5	CIT-7	17	-
25	-	4	Silica CIT-7	175	6	CIT-7	14	-
50	-	4	None	175	18	CIT-7	27	-
50	-	4	Silica CIT-7	175	4	CIT-7	28	-
100	-	4	Silica CIT-7	175	4	CIT-7	36	-
250	-	4	Silica CIT-7	175	4	CIT-7	225	-
-	50	4	Silica CIT-7	175	7	CIT-7	-	63
-	100	4	Silica CIT-7	175	7	CIT-7	-	88
^a Since STW and CIT-7 were competing products some syntheses produced pure phase versions (per XPD) of those molecular sieves ^b Determined using EDS of calcined material								

Table S2. Hydroxide mediated synthesis results.

Gel Si/Al	Gel Na/Si	Gel ROH/Si	Gel H2O/Si	Temp (°C)	Seeds	Time (days)	Product	Product Si/Al
5ª	0.25	0.16	30	160	Silica CIT-7	35	CIT-7	9
10 ^a	0.25	0.16	30	160	None	20	CIT-7	12
15ª	0.16	0.16	30	160	None	35	IWV	
15ª	0.16	0.16	30	160	Silica CIT-7	10	CIT-7	18.4 H ⁺ form
15ª	0.16	0.16	30	160	Silica CIT-7	10	CIT-7	9
30 ^b				175	None	18	IWV	29
30 ^b				175	Silica CIT-7	23	IWV+CIT-7	
^a Made using Ludox AS-40 and sodium aluminate								
^b Made from CBV760								

2. Characterization



Figure S1. XPD pattern of calcined pure-silica CIT-7 produced in fluoride media.



Figure S2. ¹³C CP-MAS NMR of as-made CIT-7 (upper) showing the occluded OSDA and comparison to the liquid NMR (lower, methanol added as an internal standard).



Figure S3. Argon isotherm of CIT-7.



Figure S4. Log plot argon adsorption isotherm.



Figure S5. ¹⁹F NMR of as-made CIT-7, spinning side bands are marked with an asterisk.



Figure S6. SEM images of calcined, pure-silica CIT-7.



Figure S7. XPD pattern of calcined aluminosilicate CIT-7 produced in fluoride media with gel Si/Al=50.



Figure S8. XPD pattern of calcined ITQ-27.



Figure S9. XPD pattern of as-made CIT-7 produced in hydroxide media with gel Si/Al=15.



Figure S10. ²⁷Al MAS NMR of aluminosilicate CIT-7. Upper is fluoride mediated synthesis with gel Si/Al=15 and lower is hydroxide mediated synthesis with gel Si/Al=5. The sample made in hydroxide media is 95% tetrahedral aluminum and the sample made in fluoride media is 88% tetrahedral aluminum.



Figure S11. UV-VIS of titanosilicate CIT-7.

3. Structure Determination

3.1 Rotation Electron Diffraction Data Collection

Large tilt steps $(0.5^{\circ}/0.35^{\circ})$ had to be used for these measurements, because the RED software to perform the finer tilts by tilting the electron beam had not yet been implemented to the JEOL 2010 TEM. As a result, the RED data were not of optimal quality.

Table S3. RED data collection.

	Dataset 1	Dataset 2	Merged dataset
Tilt range (in °)	-55 -> +60	-55 -> +60	/
Tilt step size (in °)	0.50	0.35	/
Number of 2-dimensional ED images	262	296	/
Collected reflections	2312	2248	3590
Independent reflections	1315	1289	2007
Data resolution (in Å)	1.0	1.0	1.0
Agreement factor of the reflection intensities for Friedel pairs	11.7%	22.1%	16.8%
Data completeness	56.0%	54.9%	85.5%



Figure S12. 3D electron diffraction tomography data (left) collected from a calcined, pure-silica CIT-7 (right).

3.2 Synchrotron XPD Data Collection.

Table S4. Synchrotron XPD data collection.

Synchrotron facility	2-1 Beamline at SSRL			
Wavelength	0.99995 Å			
Diffraction geometry	Debye-Scherrer			
Analyzer crystal	Si 1 1 1			
Sample	Rotating 0.5 mm capillary			
2θ range	3.5-73.5°			
Step size	0.004°2θ			
Time per step				
3.5-5.8°20	2.0 s			
5.8-19.8°20	4.0 s			
19.8-73.5°20	6.0 s			

4. Description of The CIT-7 Framework Structure

4.1 Natural Tiling Analysis of the CIT-7 Framework



Figure S13. Tiling of the CIT-7 framework built by 4 different types of tiles [5².6²] (blue), [4⁴.5²] (Orange), [4².5⁴.6²] (green) and [4⁸.5⁴.6⁸.8².10²] (purple), viewing down the [011] projection (left) and the [111] projection (right). The software TOPOS [S1] was used to analyze the framework topology, and the software 3dt [S2] was used for visualizing the tiles.

Transitivity: [(10)(20)(16)4]; Natural Tiling Signature: 2[5².6²]+2[4⁴.5²]+[4².5⁴.6²]+[4⁸.5⁴.6⁸.8².10²]

Coordination Sequences:

Si1: 4 12 17 27 49 79 99 120 146 192	Si2: 4 9 18 30 49 73 100 117 150 203
Si3: 4 10 18 31 47 75 98 124 156 189	Si4: 4 10 19 32 55 70 89 124 160 199
Si5: 4 12 20 29 49 73 100 129 157 186	Si6: 4 10 21 35 46 65 99 134 162 191
Si7: 4 9 19 37 50 66 92 126 164 200	Si8: 4 10 18 30 48 71 105 126 145 193
Si9: 4 9 18 32 48 69 95 131 160 182	Si10: 4 11 19 30 45 73 102 125 156 187

4.2 The crystallographic information file (cif) for the pure-silica CIT-7.

data all-silica CIT-7 _chemical_name_systematic "CIT-7" chemical formula structural _cell_length_a 13.0187(1)_cell_length_b 11.2063(1)_cell_length_c 9.3758(1) _cell_angle_alpha 92.8224(6) _cell_angle_beta 107.2048(5)_cell_angle_gamma 103.2565(5)symmetry space group name H-M 'P-1' _symmetry_Int_Tables_number 2 symmetry cell setting triclinic loop _symmetry_equiv_pos_as_xyz '+x,+y,+z' '-x,-y,-z' loop atom site label atom site type symbol _atom_site_occupancy atom site fract x atom site fract y _atom_site fract z atom site U iso or equiv O1 O 1.0000 0.2236(2) 0.5059(3) 0.0497(2) 1.07(10) O2 O 1.0000 0.3564(1) 0.4201(2) 0.2714(5) 1.07 O3 O 1.0000 0.3240(2) 0.6411(2) 0.3146(3) 1.07 O4 O 1.0000 0.1662(1) 0.4463(4) 0.2860(1) 1.07 O5 O 1.0000 0.3703(1) 0.6646(2) 0.9715(3) 1.07 O6 O 1.0000 0.1691(1) 0.5937(2) 0.7893(2) 1.07 O7 O 1.0000 0.2986(1) 0.4377(2) 0.8372(3) 1.07 O8 O 1.0000 0.3411(3) 0.2514(1) 0.7003(3) 1.07 O9 O 1.0000 0.4275(3) 0.4816(3) 0.6650(3) 1.07 O10 O 1.0000 0.2112(2) 0.3738(3) 0.5487(3) 1.07 O11 O 1.0000 0.1312(2) 0.5669(1) 0.4991(2) 1.07 O12 O 1.0000 1.0012(2) 0.3462(3) 0.3897(2) 1.07 O13 O 1.0000 0.3314(3) 0.0139(1) 0.6712(3) 1.07 O14 O 1.0000 0.5093(1) 0.1725(3) 0.6611(2) 1.07 O15 O 1.0000 0.4571(2) 0.1536(2) 0.9168(3) 1.07 O16 O 1.0000 0.4093(5) 0.8471(2) 0.8129(3) 1.07 O17 O 1.0000 0.2014(1) 0.7903(2) 0.6425(2) 1.07 O18 O 1.0000 0.3636(1) 0.8314(3) 0.5162(2) 1.07 O19 O 1.0000 0.4693(2) 0.3106(2) 0.1474(2) 1.07 O20 O 1.0000 0.4992(2) 0.3135(2) 0.4408(2) 1.07 Si1 Si 1.0000 0.2680(1) 0.5033(1) 0.2286(2) 0.80(5) Si2 Si 1.0000 0.2646(1) 0.5496(2) 0.9108(1) 0.80 Si3 Si 1.0000 0.3210(2) 0.3874(1) 0.6886(2) 0.80 Si4 Si 1.0000 0.1261(1) 0.4313(1) 0.4305(2) 0.80 Si5 Si 1.0000 0.4105(2) 0.1493(2) 0.7367(1) 0.80 Si6 Si 1.0000 0.3255(1) 0.8692(2) 0.6586(2) 0.80 0.1261(1) 0.6529(1) 0.6366(2) 0.80 Si7 Si 1.0000 Si8 Si 1.0000 0.4754(2) 0.3911(2) 0.2987(2) 0.80Si9 Si 1.0000 0.4638(2) 0.7620(1) 0.9296(2) 0.80Si10 Si1.0000 0.4203(1) 0.7469(2) 0.4335(2) 0.80

5. References

[S1] V. A. Blatov, O. Delgado-Friedrichs, M. O'Keeffe, D. M. Proserpio, *Acta Cryst. A.*, 2007, 63, 418–425.
[S2] O. Delgado-Friedrichs, M. O'Keeffe, *Acta Cryst. A.*, 2003, 59, 351-360.